

74AC74, 74ACT74

Dual D-Type Positive Edge-Triggered Flip-Flop

The AC/ACT74 is a dual D-type flip-flop with Asynchronous Clear and Set inputs and complementary (Q, Q) outputs. Information at the input is transferred to the outputs on the positive edge of the clock pulse. Clock triggering occurs at a voltage level of the clock pulse and is not directly related to the transition time of the positive-going pulse. After the Clock Pulse input threshold voltage has been passed, the Data input is locked out and information present will not be transferred to the outputs until the next rising edge of the Clock Pulse input.

Rochester Electronics Manufactured Components

Rochester branded components are manufactured using either die/wafers purchased from the original suppliers or Rochester wafers recreated from the original IP. All re-creations are done with the approval of the Original Component Manufacturer (OCM).

Parts are tested using original factory test programs or Rochester developed test solutions to guarantee product meets or exceeds the OCM data sheet.

Quality Overview

- ISO-9001
- AS9120 certification
- Qualified Manufacturers List (QML) MIL-PRF-35835
 - Class Q Military
 - Class V Space Level
- Qualified Suppliers List of Distributors (QSLD)
 - Rochester is a critical supplier to DLA and meets all industry and DLA standards.

Rochester Electronics, LLC is committed to supplying products that satisfy customer expectations for quality and are equal to those originally supplied by industry manufacturers.

The original manufacturer's datasheet accompanying this document reflects the performance and specifications of the Rochester manufactured version of this device. Rochester Electronics guarantees the performance of its semiconductor products to the original OCM specifications. 'Typical' values are for reference purposes only. Certain minimum or maximum ratings may be based on product characterization, design, simulation, or sample testing.



74AC74, 74ACT74 Dual D-Type Positive Edge-Triggered Flip-Flop

Features

- I_{CC} reduced by 50%
- Output source/sink 24mA
- ACT74 has TTL-compatible inputs

General Description

The AC/ACT74 is a dual D-type flip-flop with Asynchronous Clear and Set inputs and complementary $(Q,\ \overline{Q})$ outputs. Information at the input is transferred to the outputs on the positive edge of the clock pulse. Clock triggering occurs at a voltage level of the clock pulse and is not directly related to the transition time of the positive-going pulse. After the Clock Pulse input threshold voltage has been passed, the Data input is locked out and information present will not be transferred to the outputs until the next rising edge of the Clock Pulse input.

Asynchronous Inputs:

- LOW input to \overline{S}_D (Set) sets Q to HIGH level
- LOW input to CD (Clear) sets Q to LOW level
- Clear and Set are independent of clock
- Simultaneous LOW on \overline{C}_D and \overline{S}_D makes both Q and \overline{Q} HIGH

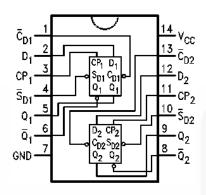
Ordering Information

Order Number	Package Number	Package Description					
74AC74SC	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow					
74AC74SJ	M14D	14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide					
74AC74MTC	MTC14	14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide					
74AC74PC	N14A	14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide					
74ACT74SC	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow					
74ACT74SJ	M14D	14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide					
74ACT74MTC	MTC14	14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide					
74ACT74PC	N14A	14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide					

Device also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering number.

All packages are lead free per JEDEC: J-STD-020B standard.

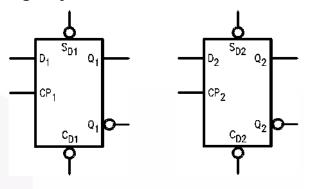
Connection Diagram



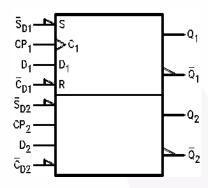
Pin Descriptions

Pin Names	Description
D ₁ , D ₂	Data Inputs
CP ₁ , CP ₂	Clock Pulse Inputs
$\overline{C}_{D1}, \overline{C}_{D2}$	Direct Clear Inputs
$\overline{S}_{D1}, \overline{S}_{D2}$	Direct Set Inputs
$Q_1, \overline{Q}_1, Q_2, \overline{Q}_2$	Outputs

Logic Symbols



IEEE/IEC



Truth Table

(Each Half)

	Inpu	Out	puts		
S _D		СР	D	Q	Q
L	Н	X	Х	Н	L
Н	L	X	Х	L	Н
L	L	X	Х	Н	Н
Н	Н	~	Н	Н	L
Н	Н	~	L	L	Н
Н	Н	L	Х	Q_0	\overline{Q}_0

H = HIGH Voltage Level

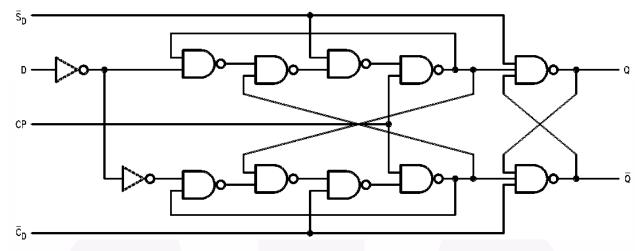
L = LOW Voltage Level

X = Immaterial

✓ = LOW-to-HIGH Clock Transition

 $Q_0(\overline{Q}_0)$ = Previous Q(\overline{Q}) before LOW-to-HIGH Transition of Clock

Logic Diagram



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

Absolute Maximum Ratings

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only.

Symbol	Parameter	Rating
V _{CC}	Supply Voltage	-0.5V to +7.0V
I _{IK}	DC Input Diode Current	
	$V_{I} = -0.5V$	–20mA
	$V_{I} = V_{CC} + 0.5$	+20mA
VI	DC Input Voltage	-0.5V to V _{CC} + 0.5V
I _{OK}	DC Output Diode Current	
	$V_{O} = -0.5V$	–20mA
	$V_{O} = V_{CC} + 0.5V$	+20mA
Vo	DC Output Voltage	-0.5V to V _{CC} + 0.5V
Io	DC Output Source or Sink Current	±50mA
I _{CC} or I _{GND}	DC V _{CC} or Ground Current per Output Pin	±50mA
T _{STG}	Storage Temperature	−65°C to +150°C
TJ	Junction Temperature	140°C

Recommended Operating Conditions

The Recommended Operating Conditions table defines the conditions for actual device operation. Recommended operating conditions are specified to ensure optimal performance to the datasheet specifications. Fairchild does not recommend exceeding them or designing to absolute maximum ratings.

Symbol	Parameter	Rating
V _{CC}	Supply Voltage	
	AC	2.0V to 6.0V
	ACT	4.5V to 5.5V
VI	Input Voltage	0V to V _{CC}
Vo	Output Voltage	0V to V _{CC}
T _A	Operating Temperature	-40°C to +85°C
ΔV / Δt	Minimum Input Edge Rate, AC Devices:	125mV/ns
	V_{IN} from 30% to 70% of V_{CC} , V_{CC} @ 3.3V, 4.5V, 5.5V	
ΔV / Δt	Minimum Input Edge Rate, ACT Devices:	125mV/ns
	V _{IN} from 0.8V to 2.0V, V _{CC} @ 4.5V, 5.5V	

DC Electrical Characteristics for AC

		V _{CC}		T _A = +	+25°C	T _A = -40°C to +85°C	
Symbol	Parameter	(V)	Conditions	Тур.	G	uaranteed Limits	Units
V _{IH}	Minimum HIGH Level	3.0	$V_{OUT} = 0.1V$ or	1.5	2.1	2.1	V
	Input Voltage	4.5	V _{CC} – 0.1V	2.25	3.15	3.15	
		5.5		2.75	3.85	3.85	
V _{IL}	Maximum LOW Level	3.0	$V_{OUT} = 0.1V$ or	1.5	0.9	0.9	V
	Input Voltage	4.5	V _{CC} – 0.1V	2.25	1.35	1.35	
		5.5		2.75	1.65	1.65	
V _{OH}	Minimum HIGH Level 3.0 $I_{OUT} = -50\mu A$	$I_{OUT} = -50\mu A$	2.99	2.9	2.9	V	
	Output Voltage	4.5		4.49	4.4	4.4	
		5.5		5.49	5.4	5.4	
		3.0	$V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OH} = -12\text{mA}$		2.56	2.46	
		4.5	$V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OH} = -24\text{mA}$		3.86	3.76	
		5.5	$V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OH} = -24\text{mA}^{(1)}$		4.86	4.76	
V _{OL}	Maximum LOW Level	3.0	$I_{OUT} = 50\mu A$	0.002	0.1	0.1	V
	Output Voltage	4.5		0.001	0.1	0.1	
		5.5		0.001	0.1	0.1	
		3.0	$V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OL} = 12\text{mA}$		0.36	0.44	
		4.5	$V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OL} = 24\text{mA}$		0.36	0.44	
		5.5	$V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OL} = 24\text{mA}^{(1)}$		0.36	0.44	
I _{IN} ⁽³⁾	Maximum Input Leakage Current	5.5	$V_I = V_{CC}$, GND		±0.1	±1.0	μA
I _{OLD}	Minimum Dynamic	5.5	V _{OLD} = 1.65V Max.			75	mA
I _{OHD}	Output Current ⁽²⁾	5.5	V _{OHD} = 3.85V Min.			– 75	mA
I _{CC} ⁽³⁾	Maximum Quiescent Supply Current	5.5	$V_{IN} = V_{CC}$ or GND		2.0	20.0	μA

Notes:

- 1. All outputs loaded; thresholds on input associated with output under test.
- 2. Maximum test duration 2.0ms, one output loaded at a time.
- 3. I_{IN} and I_{CC} @ 3.0V are guaranteed to be less than or equal to the respective limit @ 5.5V V_{CC} .

DC Electrical Characteristics for ACT

		V _{CC}		T _A = +	+25°C	T _A = -40°C to +85°C	
Symbol	Parameter	(V)	Conditions	Тур.	G	Guaranteed Limits	Units
V _{IH}	Minimum HIGH Level	4.5	$V_{OUT} = 0.1V$ or	1.5	2.0	2.0	V
	Input Voltage	5.5	V _{CC} – 0.1V	1.5	2.0	2.0	1
V _{IL}	Maximum LOW Level	4.5	$V_{OUT} = 0.1V$ or	1.5	0.8	0.8	V
	Input Voltage	5.5	V _{CC} – 0.1V	1.5	0.8	0.8	
V _{OH}	Minimum HIGH Level	4.5	$I_{OUT} = -50\mu A$	4.49	4.4	4.4	V
	Output Voltage	5.5		5.49	5.4	5.4	
		4.5	$V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OH} = -24\text{mA}$		3.86	3.76	
		5.5	$V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OH} = -24\text{mA}^{(4)}$		4.86	4.76	
V _{OL}	Maximum LOW Level	4.5	$I_{OUT} = 50\mu A$	0.001	0.1	0.1	V
	Output Voltage	5.5		0.001	0.1	0.1	
		4.5	$V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OL} = 24\text{mA}$		0.36	0.44	
		5.5	$V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OL} = 24\text{mA}^{(4)}$		0.36	0.44	
I _{IN}	Maximum Input Leakage Current	5.5	$V_I = V_{CC}$, GND		±0.1	±1.0	μA
I _{CCT}	Maximum I _{CC} /Input	5.5	$V_I = V_{CC} - 2.1V$	0.6		1.5	mA
I _{OLD}	Minimum Dynamic	5.5	V _{OLD} = 1.65V Max.			75	mA
I _{OHD}	Output Current ⁽⁵⁾	5.5	V _{OHD} = 3.85V Min.			- 75	mA
I _{CC}	Maximum Quiescent Supply Current	5.5	$V_{IN} = V_{CC}$ or GND		2.0	20.0	μА

Notes:

4. All outputs loaded; thresholds on input associated with output under test.

AC Electrical Characteristics for AC

			T _A = +25°C, C _L = 50pF		$T_A = -40$ °C to +85°C, $C_L = 50$ pF			
Symbol	Parameter	V _{CC} (V) ⁽⁶⁾	Min.	Тур.	Max.	Min.	Max.	Units
f _{MAX}	Maximum Clock Frequency	3.3	100	125		95		MHz
		5.0	140	160		125		
t _{PLH}	Propagation Delay,	3.3	3.5	8.0	12.0	2.5	13.0	ns
	\overline{C}_{Dn} or \overline{S}_{Dn} to Q_n or \overline{Q}_n	5.0	2.5	6.0	9.0	2.0	10.0	
t _{PHL}	Propagation Delay,	3.3	4.0	10.5	12.0	3.5	13.5	ns
	\overline{C}_{Dn} or \overline{S}_{Dn} to Q_n or \overline{Q}_n	5.0	3.0	8.0	9.5	2.5	10.5	
t _{PLH}	Propagation Delay,	3.3	4.5	8.0	13.5	4.0	16.0	ns
	CP_n to Q_n or \overline{Q}_n	5.0	3.5	6.0	10.0	3.0	10.5	
t _{PHL}			3.5	8.0	14.0	3.5	14.5	ns
	CP_n to Q_n or \overline{Q}_n	5.0	2.5	6.0	10.0	2.5	10.5	

Note:

5. Voltage range 3.3 is $3.3V \pm 0.3V$. Voltage range 5.0 is $5.0V \pm 0.5V$.

AC Operating Requirements for AC

				⊦25°C, 50pF	$T_A = -40$ °C to +85°C, $C_L = 50$ pF	
Symbol	Parameter	V _{CC} (V) ⁽⁷⁾	Тур.	Gua	ranteed Minimum	Units
t _S	Set-up Time, HIGH or LOW,	3.3	1.5	4.0	4.5	ns
	D _n to CP _n	5.0	1.0	3.0	3.0	
t _H	Hold Time, HIGH or LOW,	3.3	-2.0	0.5	0.5	ns
	D _n to CP _n	5.0	-1.5	0.5	0.5	
t _W	CP_n or \overline{C}_{Dn} or \overline{S}_{Dn} Pulse Width	3.3	3.0	5.5	7.0	ns
		5.0	2.5	4.5	5.0	
t _{rec}	Recovery Time, \overline{C}_{Dn} or \overline{S}_{Dn} to CP	3.3	-2.5	0	0	ns
		5.0	-2.0	0	0	

Note:

6. Voltage range 3.3 is $3.3V \pm 0.3V$. Voltage range 5.0 is $5.0V \pm 0.5V$.

AC Electrical Characteristics for ACT

			T _A = +25°C, C _L = 50pF		$T_A = -40$ °C to +85°C, $C_L = 50$ pF			
Symbol	Parameter	V _{CC} (V) ⁽⁸⁾	Min.	Тур.	Max.	Min.	Max.	Units
f _{MAX}	Maximum Clock Frequency	5.0	145	210		125		MHz
t _{PLH}	Propagation Delay, \overline{C}_{Dn} or \overline{S}_{Dn} to Q_n or \overline{Q}_n	5.0	3.0	5.5	9.5	2.5	10.5	ns
t _{PHL}	Propagation Delay, \overline{C}_{Dn} or \overline{S}_{Dn} to Q_n or \overline{Q}_n	5.0	3.0	6.0	10.0	3.0	11.5	ns
t _{PLH}	Propagation Delay, CP_n to Q_n or \overline{Q}_n	5.0	4.0	7.5	11.0	4.0	13.0.	ns
t _{PHL}	Propagation Delay, CP_n to Q_n or \overline{Q}_n	5.0	3.5	6.0	10.0	3.0	11.5	ns

Note:

7. Voltage range 5.0 is $5.0V \pm 0.5V$.

AC Operating Requirements for ACT

				-25°C, 50pF	$T_A = -40$ °C to +85°C, $C_L = 50$ pF	
Symbol	Parameter	V _{CC} (V) ⁽⁹⁾	Тур.	Gua	aranteed Minimum	Units
t _S	Set-up Time, HIGH or LOW, D _n to CP _n	5.0	1.0	3.0	3.5	ns
t _H	Hold Time, HIGH or LOW, D _n to CP _n	5.0	-0.5	1.0	1.0	ns
t _W	CP_n or \overline{C}_{Dn} or \overline{S}_{Dn} Pulse Width	5.0	3.0	5.0	6.0	ns
t _{rec}	Recovery Time, \overline{C}_{Dn} or \overline{S}_{Dn} to CP	5.0	-2.5	0	0	ns

Note:

8. Voltage range 5.0 is $5.0V \pm 0.5V$.

Capacitance

Symb	ol	Parameter	Conditions	Тур.	Units
C _{IN}		Input Capacitance	V _{CC} = OPEN	4.5	pF
C _{PD}		Power Dissipation Capacitance	V _{CC} = 5.0V	35.0	pF

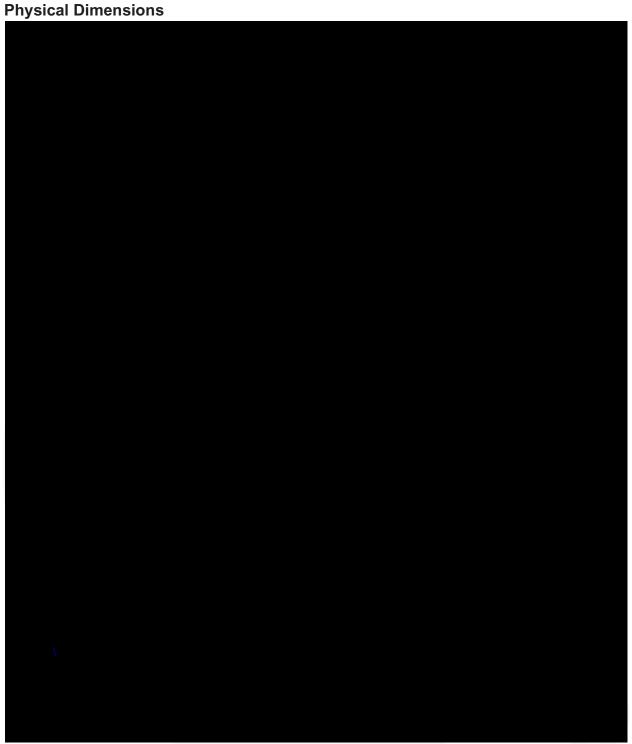


Figure 1. 14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow

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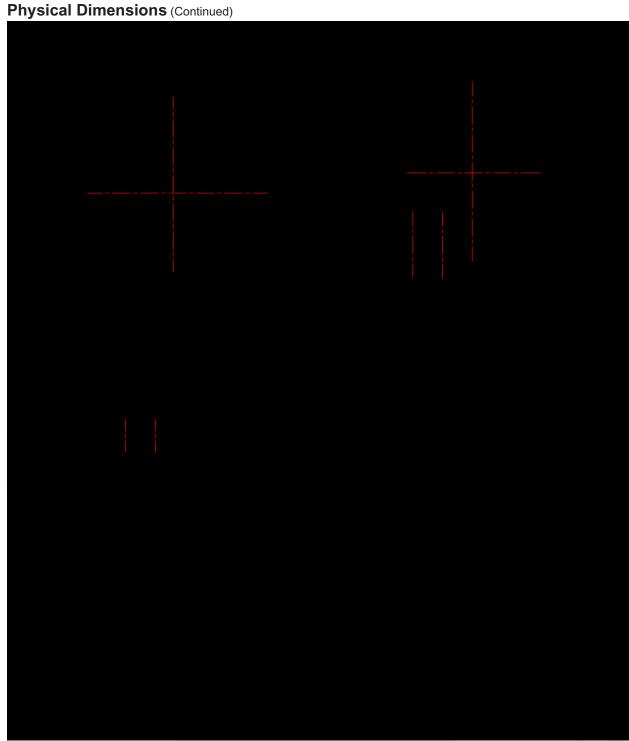
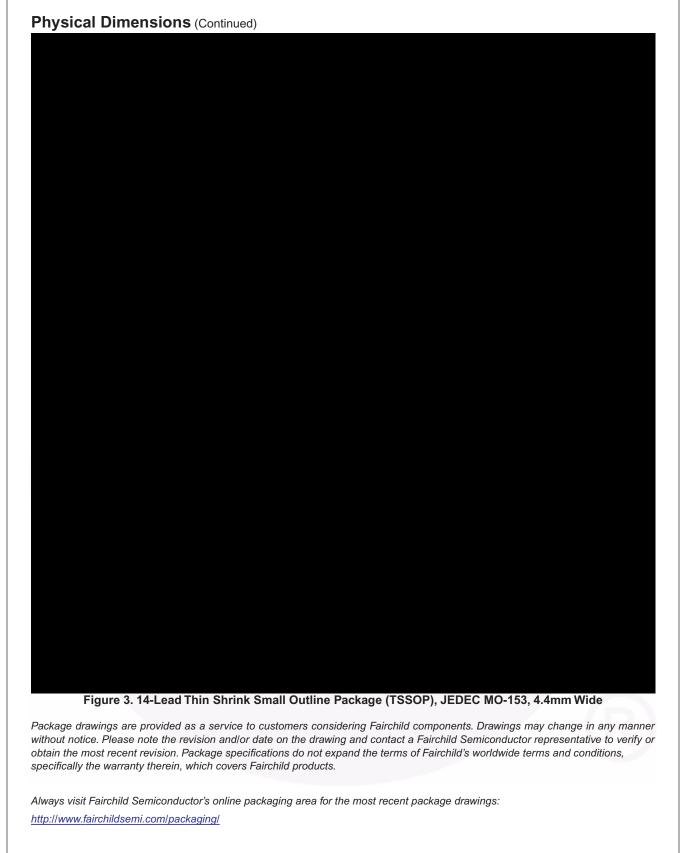


Figure 2. 14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide

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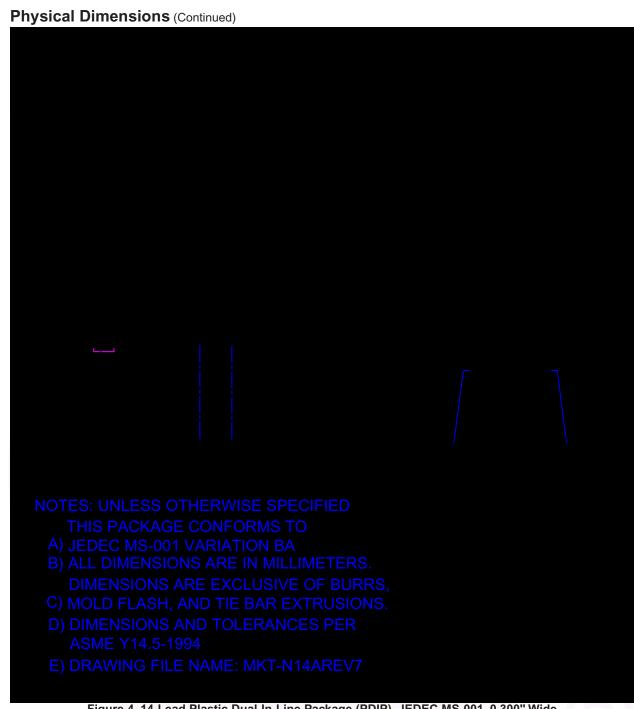


Figure 4. 14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide

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